Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10767168	NAKAYA ET AL.
Examiner	Art Unit
Riley, Marcus T	2625

SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES					
Search Notes	Date	Examiner			
(358/496) text search - see search history printouts	5/14/2007	MTR			
(358/497) text search - see search history printouts	5/14/2007	MTR			
(358/496) text search - see search history printouts	11/23/2007	MTR			
(358/497) text search - see search history printouts	11/23/2007	MTR			
Google Search - Search Terms (Image, Head Unit, Direction, Predetermined, Scan, Scanner, Pixel, Update, Alter, Alterable, Micromirror, Plural, Plurality, SRAM, Retard, Slow, Error, Crystal Liquid, Laser,Irradiate,Shut, Shutter, Kanatake, Store, Storage, Memory, Image, Time, Timing,	11/23/2007	MTR			

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		

U.S. Patent and Trademark Office Part of Paper No.: 20071015